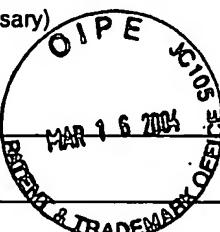


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9319G-000581	10/691,464
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U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.						

FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes	Translation * No
1.	APM/AM	2002-192740	July/2002	Japan			X
2.		2002-079693	Mar/2002	Japan			X
3.		2001-212970	Aug/2001	Japan			X
4.		2000-343686	Dec/2000	Japan			X

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

Ref. Desig.	Examiner's Initials	
1.	APM/AM	Patent Abstract of Japan 2002-192740 (2 pages)
2.	APM/AM	Patent Abstract of Japan 2002-079693 (2 pages)
3.	APM/AM	Patent Abstract of Japan 2001-212970 (2 pages)
4.	APM/AM	Patent Abstract of Japan 2000-343686 (2 pages)

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FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes	No
1.	<i>APRA</i>	11-014820	1/22/1999	Japan		X	
2.	<i>APRA</i>	2000-284113	10/13/2000	Japan		X	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

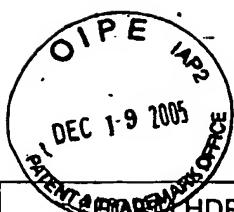
Ref. Desig.	Examiner's Initials	
1.	<i>APRA</i>	Communication from Korean Patent Office regarding counterpart application.

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FOREIGN PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes	No
1.	<i>dpn</i>	2001-015022	Jan/2001	Japan		X	
2.		2000-048716	Feb/2000	Japan		X	
3.		11-188853	July/1999	Japan		X	
4.		08-281174	Oct/1996	Japan		X	
5.	<i>dpn</i>	04-269549	Sept/1992	Japan		Abstract	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

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1.	<i>dpn</i>	Communication from Japanese Patent Office regarding related application.

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